

Electronic Supplementary Material (ESI) for RSC Advances

**Ionic Transport Kinetics and Enhanced Energy Storage in the
Electrode/Poly(*N*-vinyl imidazole) Interface for Micro-Supercapacitors**

Karthik Krishnan,*^a Selvakumar Karuthapandi,*^b and Saranyan Vijayaraghavan^a

^a *Corrosion and Material Protection Division, CSIR-Central Electrochemical Research Institute,
Karaikudi, Tamilnadu 630-003, India.*

^b *Department of Chemistry, School of Science and Languages, VIT-AP University,
Amaravati, Andhra Pradesh 522-237, India.*

E-mail: karthikk@cecri.res.in; selvakumar.k@vitap.ac.in

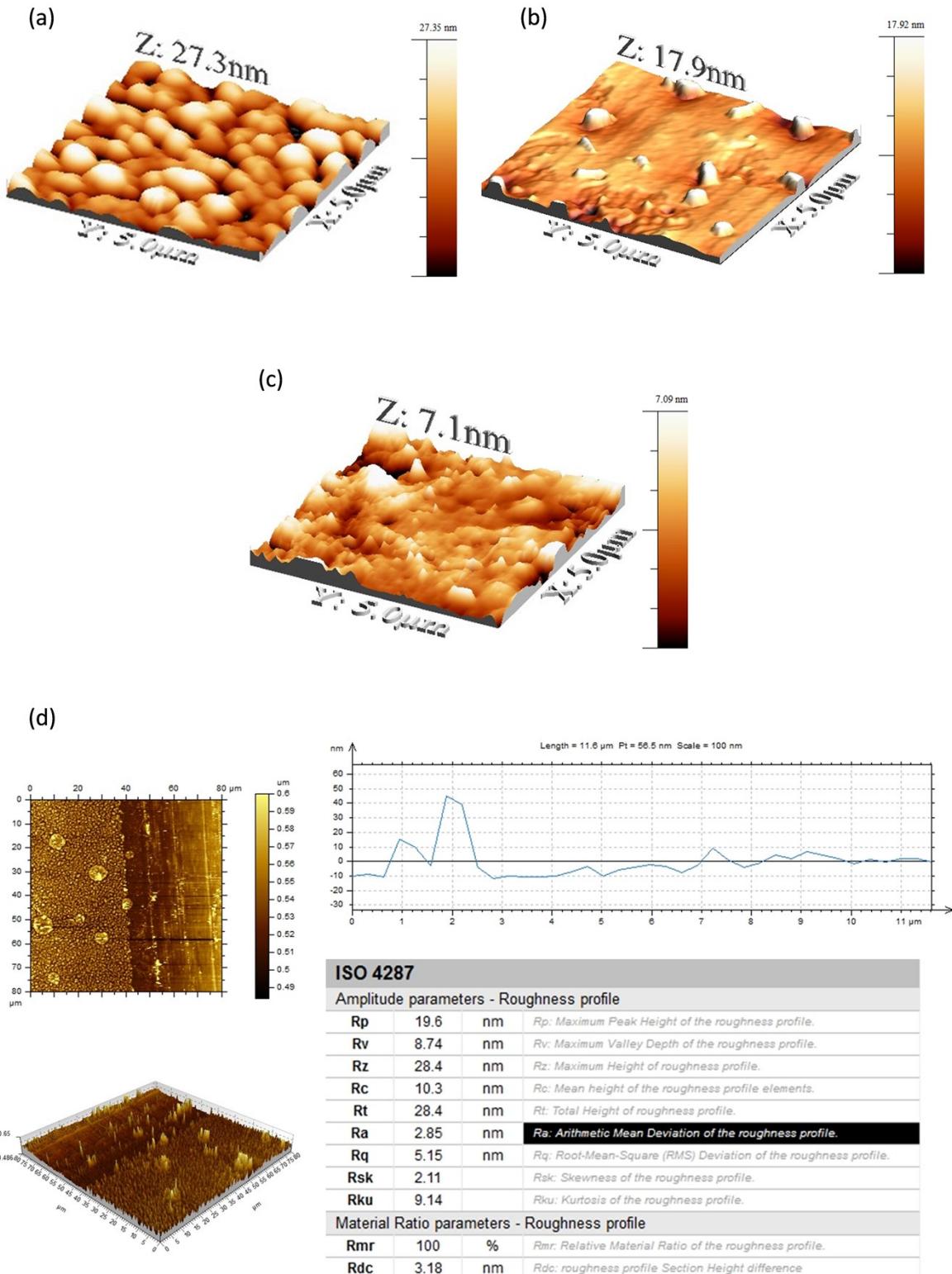


Fig. S1 3D AFM images of (a) ~ 121 nm, (b) ~ 66 nm, (c) ~ 28 nm, and (d) AFM measurement for thickness of the film (~ 28 nm) and the corresponding surface profiles.

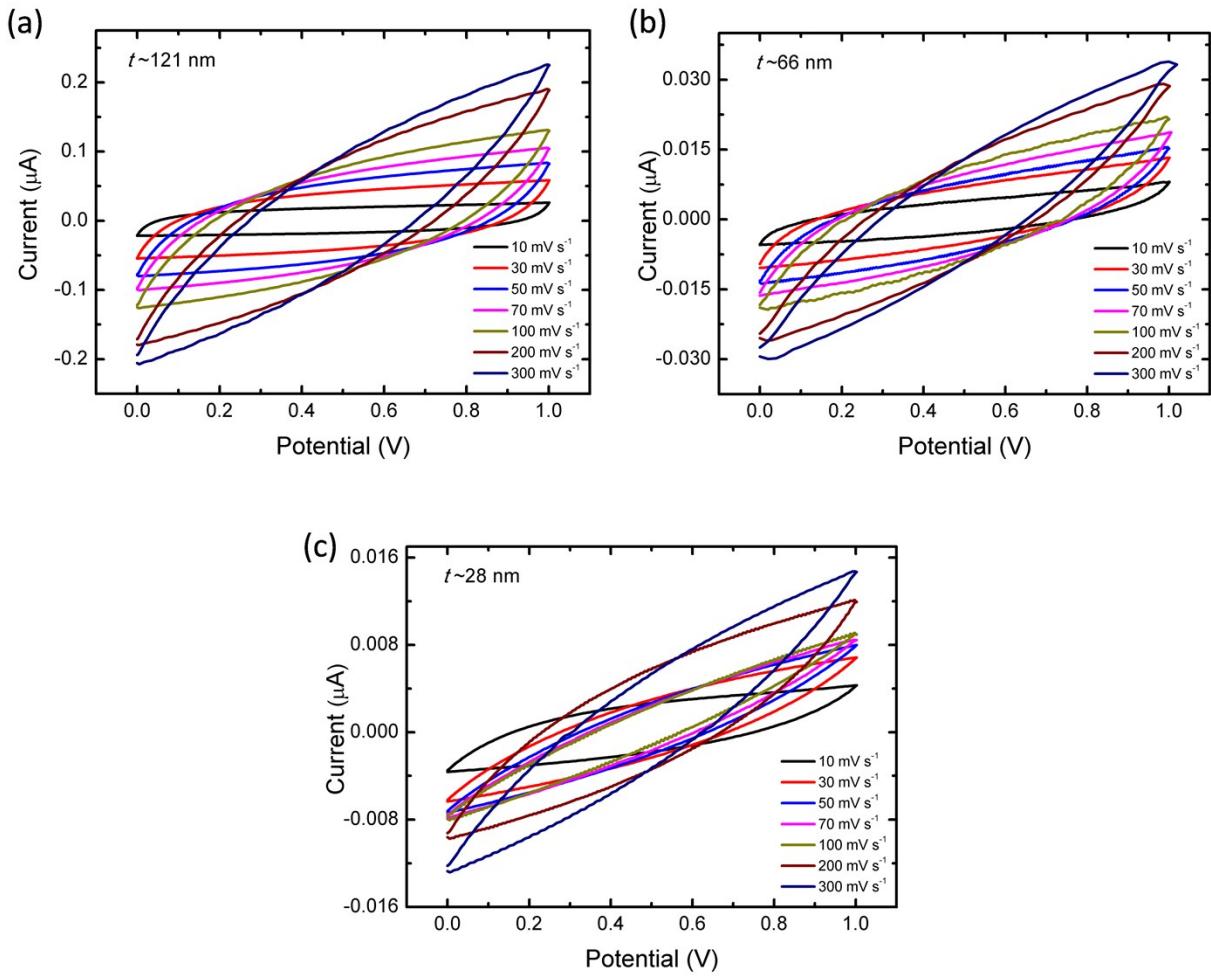


Fig. S2 Scan rate dependent CV curves of ITO/PVI-KOH/ITO planar MSC using various PVI-KOH film thicknesses ($t \approx 28$ to 121 nm).

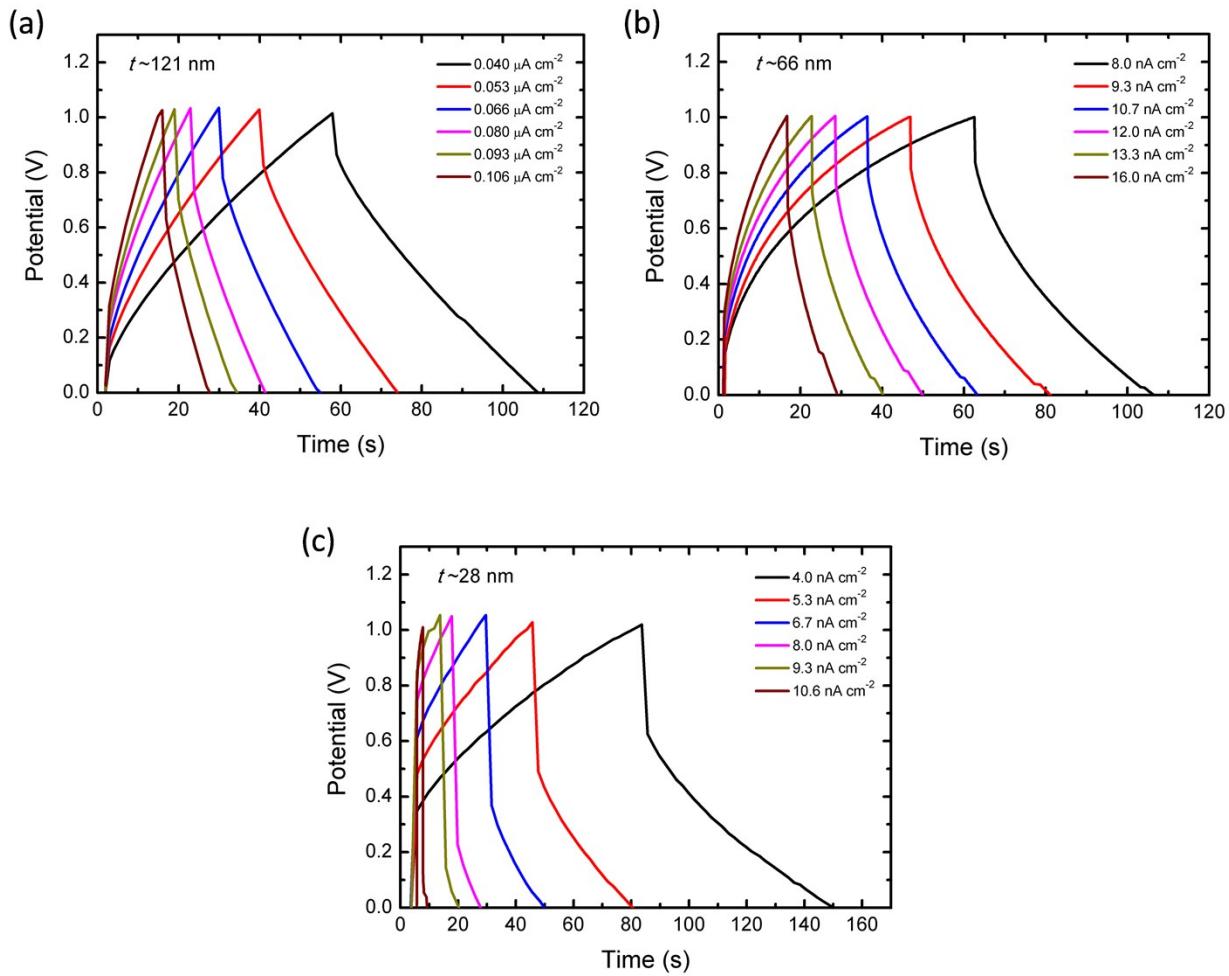


Fig. S3 PVI-KOH film thickness dependent charge–discharge profiles of the ITO/PVI-KOH/ITO planar MSC with various current densities.

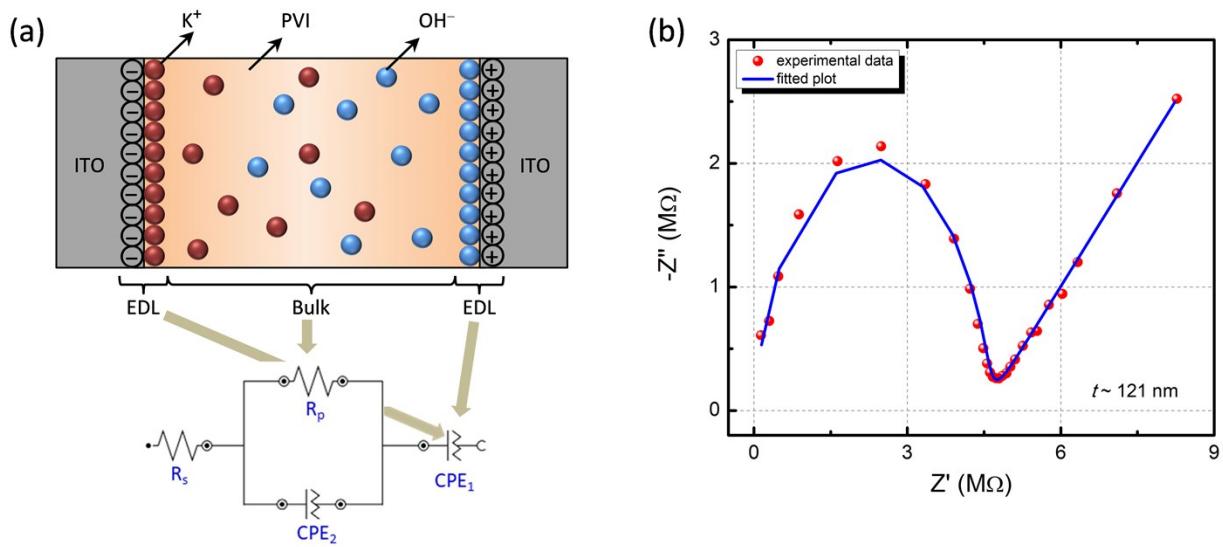


Fig. S4 (a) Equivalent circuit model describing the impedance behavior of the ITO/PVI-KOH/ITO planar MSC, and (b) the corresponding fitting plot of the device.

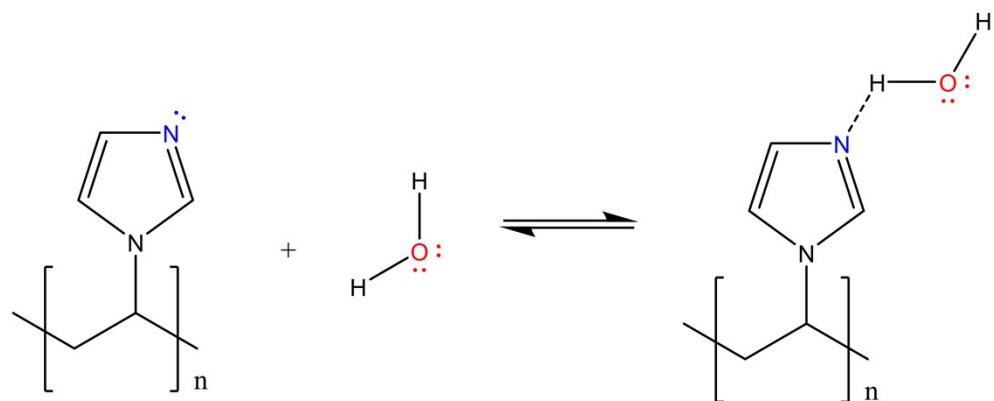


Fig. S5 Hydration of PVI through hydrogen bonding

Relative humidity (RH%) dependent ionic conductivity:

The ionic conductivity measurements were performed at room temperature and at various RH values. In the thin film, a two-probe method was used to obtain the conductivity data. The impedance data were obtained between the frequency range of 1 Hz and 1 MHz, with an applied potential of 50 mV. Atmospheres of various RH ranges were maintained by using different saturated salt solutions in their equilibrium states, including LiCl for ~11% RH, MgCl for ~32% RH, Mg(NO₃)₂ for ~51% RH, NaCl for ~75% RH, KCl for ~83% RH, KNO₃ for ~93% RH and K₂SO₄ for ~97% RH at room temperature (~30 °C).¹

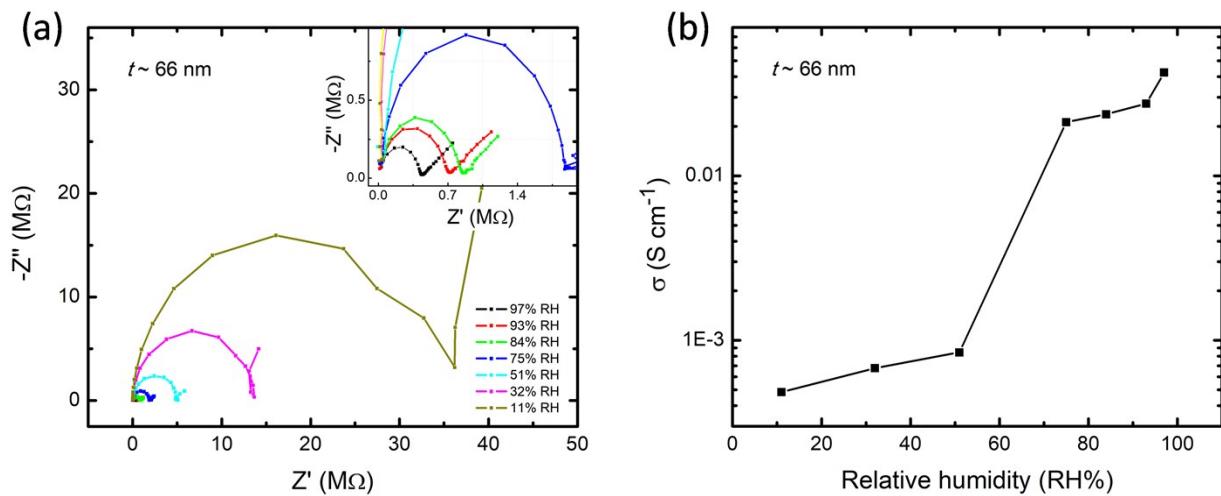


Fig. S6 (a) RH % dependent impedance plot, and (b) corresponding RH% versus ionic conductivity plot of PVI-KOH film (thickness (t) \sim 66 nm).

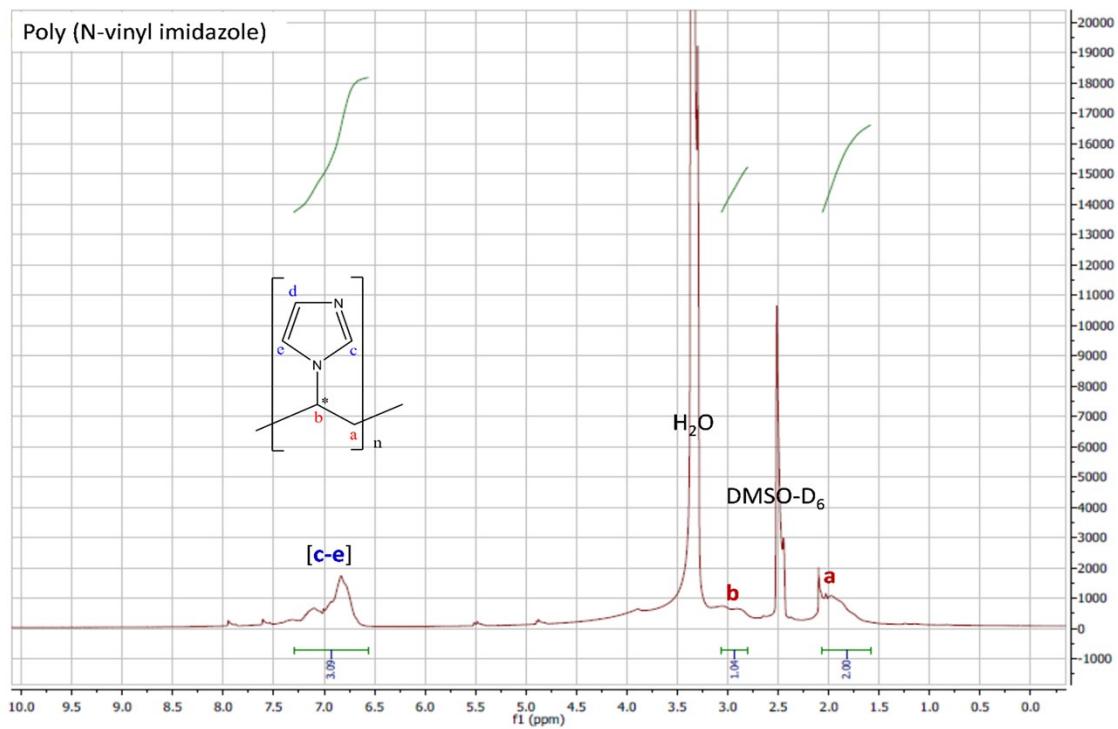


Table S1. Electrical double layer capacitance characteristics are compared with the reported data.

Ref. No.	Electrode	Electrolyte	Capacitance (C)
[2]	Carbon-nanotubes	PVA-H ₃ PO ₄	4.69 mF cm ⁻²
[3]	Heteroatom-doped porous graphene	PVA-H ₂ SO ₄	1.36 mF cm ⁻² at 0.15 mA cm ⁻²
[4]	Direct laser write porous carbon	PVA-H ₃ PO ₄	240 mF cm ⁻³ at 10 mV s ⁻¹
[5]	Boron-doped porous graphene	PVA-H ⁺	16.5 mF cm ⁻² at 0.05 mA cm ⁻²
[6]	RGMA ternary hybrid film	Ionic liquid gel	4.42 F cm ⁻³ at 10 mV s ⁻¹
[7]	Electrochemically reduced graphene oxide	25% KOH	0.48 mF cm ⁻² at 40 μA cm ⁻²
[8]	Transparent carbon film	PVA-H ₃ PO ₄	409 mF cm ⁻² (branched CNC)
[9]	RGO-CNT (9:1)	3 M KCl	3 F cm ⁻³ at 50 V/s
[10]	MWCNT	PVA-H ₃ PO ₄ -H ₂ O & 0.5 M H ₂ SO ₄	1.8 mF cm ⁻²
[11]	Onion-like carbon	Et ₄ NBF ₄ /anhydrous propylene carbonate electrolyte	0.9 mF cm ⁻² at 100 V/s
This work	ITO	PVI-KOH	128 mF cm ⁻³ at 10 mV s ⁻¹

The GCD profiles shows the discharging effect of the planar MSC using multimeter as load, which can be seen in the real-time movies **ITO_PVI-KOH_ITO Planar MSC.mp4**.

References

1. D. Choudhury, J. K. Sahu and G. D. Sharma, *Ind. Crop. Prod.*, 2011, **33**, 211–216.
2. W. Yu, H. Zhou, B. Q. Li and S. Ding, *ACS Appl. Mater. Interfaces*, 2017, **9(5)**, 4597–4604
3. A. Basu, K. Roy, N. Sharma, S. Nandi, R. Vaidhyanathan, S. Rane, C. Rode and S. Ogale, *ACS Appl. Mater. Interfaces*, 2016, **8(46)**, 31841–31848.
4. J. B. In, B. Hsia, J. -H. Yoo, S. Hyun, C. Carraro, R. Maboudian and C. P. Grigoropoulos, *Carbon*, 2015, **83**, 144–151
5. Z. Peng, R. Ye, J. A. Mann, D. Zakhidov, Y. Li, P. R. Smalley, J. Lin and J. M. Tour, *ACS Nano*, 2015, **9(6)**, 5868–5875.
6. W. Liu, C. Lu, X. Wang, R. Y. Tay and B. K. Tay, *ACS Nano*, 2015, **9**, 1528–1542.
7. K. Sheng, Y. Sun, C. Li, W. Yuan and G. Shi, *Sci. Rep.*, 2012, **2**, 247.
8. H. Y. Jung, M. B. Karimi, M. G. Hahm, P. M. Ajayan and Y. J. Jung, *Sci. Rep.*, 2012, **2**, 773.
9. M. Beidaghi and C. Wang, *Adv. Funct. Mater.*, 2012, **22**, 4501–4510.
10. T. M. Dinh, D. Pech, M. Brunet and A. Achour, *J. Phys.: Conf. Ser.*, 2013, **476**, 012106.
11. D. Pech, M. Brunet, H. Durou, P. Huang, V. Mochalin, Y. Gogotsi, P. -L. Taberna and P. Simon, *Nat. Nanotechnol.*, 2010, **5**, 651–654.